

**Notice of References Cited**

Application/Control No.

10/668,559

Applicant(s)/Patent Under  
Reexamination  
ZUBER ET AL.

Examiner

Karie O'Neill

Art Unit

1795

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N	JP 10154521 A	06-1998	Japan	FUKUOKA et al.	
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